

<b>Notice of References Cited</b>	Application/Control No. 10/044,178	Applicant(s)/Patent Under Reexamination EDGAR, TODD	
	Examiner Thao X Le	Art Unit 2814	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,028,990	07-1991	Kotaki et al.	257/306
	B	US-5,494,841	02-1996	Dennison et al.	438/210
	C	US-5,739,068	04-1998	Jost et al.	438/637
	D	US-5,369,048	11-1994	Hsue, Chen-Chiu	438/396
	E	US-5,262,662	11-1993	Gonzalez et al.	257/307
	F	US-5,120,674	06-1992	Chin et al.	438/396
	G	US-5,521,408	05-1996	Rha et al.	257/309
	H	US-5,796,135	08-1998	Liang et al.	257/296
	I	US-5,723,889	03-1998	Choi et al.	257/329
	J	US-5,488,011	01-1996	Figura et al.	438/253
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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